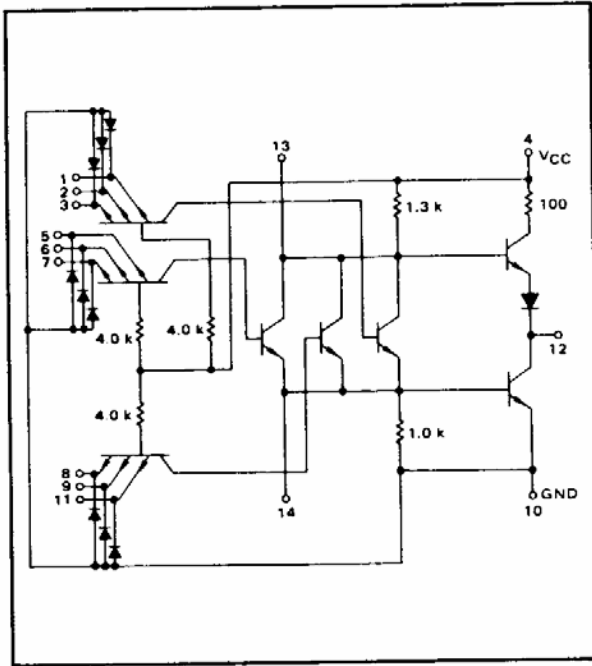


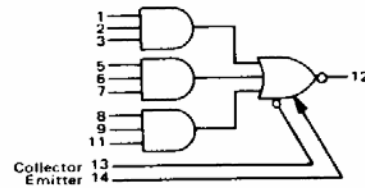
EXPANDABLE 3-WIDE 3-INPUT
"AND-OR-INVERT" GATE

MTTL I MC500/400 series

MC504 · MC554
MC404 · MC454



This device consists of three 3-input AND gates ORed together driving an output inverter. The common ORing nodes are available for expansion, and up to 10 AND gates can be ORed together using the MC509 or the MC510 series expanders. Care should be taken to minimize the amount of capacitance on the expander terminals in order to maintain switching speeds.



Positive Logic:

$$12 = (1 + 2 + 3) + (5 + 6 + 7) + (8 + 9 + 11) + (\text{Expanders})$$

Negative Logic:

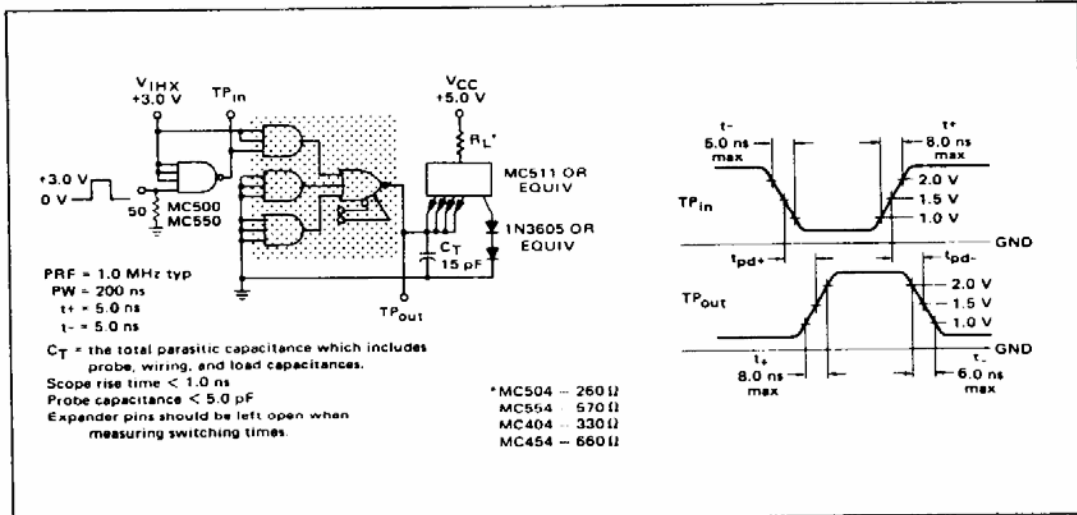
$$12 = (1 + 2 + 3) + (5 + 6 + 7) + (8 + 9 + 11) + (\text{Expanders})$$

Total Power Dissipation - 25 mW typ/pkg
Propagation Delay Time - 12 ns typ

TYPE NO.	INPUT LOADING FACTOR	(I _F)	OUTPUT DRIVE	(I _{OL})	TEMPERATURE RANGE
MC504 MC554	1	(-1.33 mA)	15 MC500 series Gates 7 MC500 series Gates	(20 mA) (10 mA)	-55°C to +125°C
MC404 MC454	1	(-1.66 mA)	12 MC400 series Gates 6 MC400 series Gates	(20 mA) (10 mA)	0° to +75°C

SWITCHING TIME TEST CIRCUIT

VOLTAGE WAVEFORMS AND DEFINITIONS



MC504, MC554/MC404, MC454 (continued)

ELECTRICAL CHARACTERISTICS

Test procedures are shown for only one input of the device. To complete testing sequence through remaining inputs in the same manner.

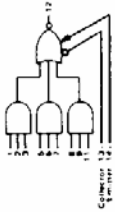


Figure 12

Characteristic	Symbol	Pin Order	TEST CONDITIONS												V _{OH}	V _{OL}	V _{CC}	V _{COH}	V _{max}				
			mA						Volts														
			I _{OL}	I _{OH}	I _{in}	I _{in}	I _{in}	I _{in}	V _{IL}	V _{OL}	V _{IL}	V _{OL}	V _{IL}	V _{OL}						V _{IL}	V _{OL}	V _{IL}	V _{OL}
			Pr*	Std	Pr*	Std	Pr*	Std	Pr*	Std	Pr*	Std	Pr*	Std						Pr*	Std	Pr*	Std
Input	Forward Current	1	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Input	Leakage Current	1	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Input	Inverse Beta Current	1	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Breakdown Voltage	BV _{in} [†]	3	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Output	Output Voltage	12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Leakage Current	I _{OLK}	12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Short-Circuit Current	I _{SC}	12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Output Voltage*	V _{OL}	12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Power Requirements	I _{max}	4	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Power Supply Drain	I _{PHL}	5	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Switching Parameters	Turn-On Delay	1,12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Switching Parameters	Turn-Off Delay	1,12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Switching Parameters	Rise Time	1,12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										
Switching Parameters	Fall Time	1,12	MC504, MC554 Test Limits												-	-	-	-	-				
			-55°C		+25°C		+125°C		0°C		+75°C		+75°C										

* Prime Fall-Out